

Notice of References Cited	Application/Control No. 10/605,744	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Christopher Findley	Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,043,838 A	03-2000	Chen, Xuemin	348/42
*	B	US-6,493,385 B1	12-2002	Sekiguchi et al.	375/240.03
*	C	US-6,785,331 B1	08-2004	Jozawa et al.	375/240.12
*	D	US-6,810,131 B2	10-2004	Nakagawa et al.	382/100
*	E	US-6,862,320 B1	03-2005	Isu et al.	375/240.27
*	F	US-7,058,128 B1	06-2006	Itokawa, Osamu	375/240.08
*	G	US-7,131,048 B2	10-2006	Suzuki et al.	714/748
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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